

CERTIFICATE OF ACCREDITATION

ANSI National Accreditation Board

11617 Coldwater Road, Fort Wayne, IN 46845 USA

This is to certify that

II-VI Optical Systems Calibration Laboratory 2710 Commerce Way Philadelphia, PA 19154

has been assessed by ANAB and meets the requirements of international standard

ISO/IEC 17025:2017

while demonstrating technical competence in the field of

CALIBRATION

Refer to the accompanying Scope of Accreditation for information regarding the types of activities to which this accreditation applies

AC-1762 Certificate Number



Certificate Valid Through: 03/05/2021 Version No. 007 Issued: 02/12/2019





SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

II-VI Optical Systems Calibration Laboratory

2710 Commerce Way Philadelphia, PA 19154 Jeremy Miller 215-842-3675 ext. 106

CALIBRATION

Valid to: March 5, 2021 Certificate Number: AC-1762

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Precision Grids, Scales and Reticles Soda Lime Glass	X= (0.003 to 100) mm	$2E-08x^2 + 4E-08x + 0.00178 \text{ mm}$	
	Y= (0.003 to 100) mm	$2E-08y^2 + 4E-08y + 0.00178 \text{ mm}$	
	X= (100 to 400) mm	$7E-09x^2 + 2E-06x + 0.001 66 \text{ mm}$	
	Y= (100 to 400) mm	$7E-09y^2 + 2E-06y + 0.001 66 \text{ mm}$	CAL-STD-01 Quartz Scale CAL-L-01 Autograph CMM MLA Procedure MI-1500-002, Autograph Calibration
	X= (400 to 1 524) mm	$2E-10x^2 + 7E-06x + 0.000 67 \text{ mm}$	
	Y= (400 to 1 524) mm	$2E-10y^2 + 7E-06y + 0.000 67 \text{ mm}$	
Precision Grids, Scales and Reticles Borofloat Glass	X= (0.003 to 400) mm	$2E-09x^2 + 6E-10x + 0.00179 \text{ mm}$	
	Y= (0.003 to 400) mm	$2E-09y^2 + 6E-10y + 0.00179 \text{ mm}$	
	X= (400 to 1 200) mm	$7E-10x^2 + 9E-07x + 0.001 56 \text{ mm}$	8F
	Y= (400 to 1 200) mm	$7E-10y^2 + 9E-07y + 0.001 56 \text{ mm}$	
	X= (1 200 to 1 524) mm	$2E-10x^2 + 2E-06x + 0.000 89 \text{ mm}$	
	Y= (1 200 to 1 524) mm	$2E-10y^2 + 2E-06y + 0.000 89 \text{ mm}$	





Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Precision Grids, Scales and Reticles Fused Silica Glass	X = (0 to 1 524) mm	$6E-11x^2 + 2E-09x + 0.001 81 \text{ mm}$	- CAL-STD-01 Quartz Scale
	Y = (0 to 1524) mm	$6E-11y^2 + 2E-09y + 0.001 81 \text{ mm}$	
Precision Grids, Scales and Reticles Silicon	X=(0.003 to 950) mm	$1E-09x^2 + 3E-07x + 0.00176 \text{ mm}$	CAL-L-01 Autograph CMM
	Y = (0.003 to 950) mm	$1E-09y^2 + 3E-07y + 0.00176 \text{ mm}$	MLA Procedure MI-1500-002, Autograph Calibration
	X= (950 to 1 524) mm	$3.7E-10x^2 + 1E-06x + 0.001 65 \text{ mm}$	
	Y= (950 to 1 524) mm	$3.7E-10y^2 + 1E-06y + 0.001 65 \text{ mm}$	

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 (*k*=2), corresponding to a confidence level of approximately 95%.

Notes

- 1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
- 2. X and Y represent length in millimeters.
- 3. This scope is formatted as part of a single document including Certificate of Accreditation No. AC-1762.



